

GSID200A120S5C1

Si IGBT Module



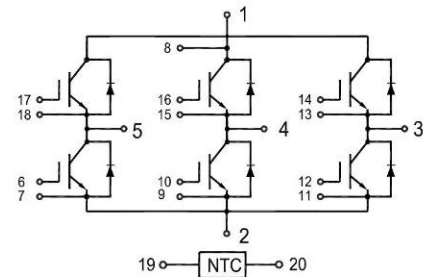
Features:

- Short Circuit Rated > 10 μ s
- Low Saturation Voltage: $V_{CE(sat)} = 1.65\text{ V @ } I_C = 200\text{ A, } T_C = 25\text{ }^\circ\text{C}$
- Low Switching Loss
- 100% RBSOA Tested ($2 \times I_C$)
- Low Stray Inductance
- Lead Free, Compliant with RoHS Requirement



Applications:

- High Power Converters
- Motor Drives
- UPS Systems



Maximum Rated Values of IGBT ($T_C = 25\text{ }^\circ\text{C}$ unless otherwise specified)

V_{CES}	Collector-Emitter Blocking Voltage		1200	V
V_{GES}	Gate-Emitter Voltage		± 20	V
I_C	Continuous Collector Current	$T_C = 80\text{ }^\circ\text{C}$	200	A
		$T_C = 25\text{ }^\circ\text{C}$	382	A
I_{CM}	Repetitive Peak Collector Current	$T_J = 175\text{ }^\circ\text{C}$	400	A
t_{sc}	Short Circuit Withstand Time		>10	μ s
P_D	Maximum Power Dissipation per IGBT	$T_C = 25\text{ }^\circ\text{C}$	1260	W
		$T_{Jmax} = 175\text{ }^\circ\text{C}$		

Electrical Characteristics of IGBT ($T_C = 25\text{ }^\circ\text{C}$ unless otherwise specified)

Static characteristics

Symbol	Description	Conditions	Min	Typ	Max	Unit	
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C = 4\text{ mA}$, $V_{CE} = V_{GE}$	4.0	5.7	6.0	V	
$V_{CE(sat)}$ (Terminal)	Collector-Emitter Saturation Voltage	$I_C = 200\text{ A}$, $V_{GE} = 15\text{ V}$	$T_J = 25\text{ }^\circ\text{C}$		1.65	1.95	V
			$T_J = 125\text{ }^\circ\text{C}$		1.85		V
			$T_J = 150\text{ }^\circ\text{C}$		1.90		V
$V_{CE(sat)}$ (Chip)	Collector-Emitter Saturation Voltage	$I_C = 200\text{ A}$, $V_{GE} = 15\text{ V}$	$T_J = 25\text{ }^\circ\text{C}$		1.65	1.90	V
			$T_J = 125\text{ }^\circ\text{C}$		1.80		V
			$T_J = 150\text{ }^\circ\text{C}$		1.85		V
I_{CES}	Collector-Emitter Leakage Current	$V_{GE} = 0\text{ V}$, $V_{CE} = V_{CES}$, $T_J = 25\text{ }^\circ\text{C}$			1	mA	
I_{GES}	Gate-Emitter Leakage Current	$V_{GE} = \pm 20\text{ V}$, $V_{CE} = 0\text{ V}$, $T_J = 25\text{ }^\circ\text{C}$			400	nA	
C_{ies}	Input Capacitance	$V_{CE} = 25\text{ V}$, $V_{GE} = 0\text{ V}$, $f = 1\text{ MHz}$		16.5		nF	
C_{res}	Reverse transfer Capacitance			0.60		nF	

Switching Characteristics

$t_{d(on)}$	Turn-on Delay Time	$V_{CC} = 600\text{ V}$, $I_C = 200\text{ A}$, $R_{Gon} = 2\text{ }\Omega$, $V_{GE} = \pm 15\text{ V}$, Inductive Load	$T_J = 25\text{ }^\circ\text{C}$		307		ns
			$T_J = 125\text{ }^\circ\text{C}$		310		
			$T_J = 150\text{ }^\circ\text{C}$		309		
t_r	Rise Time		$T_J = 25\text{ }^\circ\text{C}$		104		ns
			$T_J = 125\text{ }^\circ\text{C}$		105		
			$T_J = 150\text{ }^\circ\text{C}$		109		
$t_{d(off)}$	Turn-off Delay Time		$T_J = 25\text{ }^\circ\text{C}$		313		ns
			$T_J = 125\text{ }^\circ\text{C}$		335		
			$T_J = 150\text{ }^\circ\text{C}$		335		
t_f	Fall Time	$T_J = 25\text{ }^\circ\text{C}$		182		ns	
		$T_J = 125\text{ }^\circ\text{C}$		319			
		$T_J = 150\text{ }^\circ\text{C}$		335			

E _{on}	Turn-on Switching Loss	V _{CC} = 600 V, I _C = 200 A, R _{Gon} = 2 Ω, V _{GE} = ±15 V, di/dt = 1855 A/μs (T _J = 150 °C) Inductive Load	T _J = 25 °C	14.5	mJ
			T _J = 125 °C	19.0	
			T _J = 150 °C	20.2	
E _{off}	Turn-off Switching Loss	V _{CC} = 600 V, I _C = 200 A, R _{Goff} = 2 Ω, V _{GE} = ±15 V, dv/dt = 3767 V/μs (T _J = 150 °C) Inductive Load	T _J = 25 °C	15.7	mJ
			T _J = 125 °C	22.7	
			T _J = 150 °C	24.7	
Q _g	Total Gate Charge	V _{GE} = +15 V..._-15 V	T _J = 25 °C	1065	nC
			T _J = 125 °C	1057	
			T _J = 150 °C	1060	
R _{gint}	Internal Gate Resistor		3.75		Ω
RBSOA	Reverse Bias Safe Operation Area	I _C = 400 A, V _{CC} = 1050 V, V _p = 1200 V, R _g = 2 Ω, V _{GE} = +15 V to 0 V, T _J = 150 °C	Trapezoid		
SCSOA	Short Circuit Safe Operation Area	V _{CC} = 600 V, V _{GE} = 15 V, T _J = 150 °C	10		μs
R _{θJC}	IGBT Thermal Resistance: Junction-To-Case (per leg)			0.119	°C/W

Diode, Inverter

Maximum Rated Values (T_C = 25 °C unless otherwise specified)

V _{RRM}	Repetitive Peak Reverse Voltage	1200	V
I _F	Diode Continuous Forward Current	200	A
I _{FM}	Peak FWD Current Repetitive	400	A

Electrical Characteristics of Diode (T_C = 25 °C unless otherwise specified)

Symbol	Description	Conditions	Min	Typ	Max	Unit
V _F (Terminal)	Forward Voltage	I _F = 200 A	T _J = 25 °C	2.00		V
			T _J = 125 °C	2.20		
			T _J = 150 °C	2.10		
V _F (Chip)	Forward Voltage	I _F = 200 A	T _J = 25 °C	2.00		V
			T _J = 125 °C	2.20		
			T _J = 150 °C	2.10		

I _{rr}	Peak Reverse Recovery Current	I _F = 200 A, di/dt = 1500 A/μs, V _{rr} = 600 V, V _{GE} = -15 V	T _J = 25 °C	109	A
			T _J = 125 °C	144	
			T _J = 150 °C	155	
Q _{rr}	Reverse Recovery Charge	I _F = 200 A, di/dt = 1500 A/μs, V _{rr} = 600 V, V _{GE} = -15 V	T _J = 25 °C	13.7	μC
			T _J = 125 °C	25.5	
			T _J = 150 °C	30.1	
E _{rec}	Reverse Recovery Energy	I _F = 200 A, di/dt = 1500 A/μs, V _{rr} = 600 V, V _{GE} = -15 V	T _J = 25 °C	5.4	mJ
			T _J = 125 °C	11.7	
			T _J = 150 °C	14.3	
R _{θJC}	Diode Thermal Resistance: Junction-To-Case (per leg)			0.13	°C/W

NTC-Thermistor Characteristic values

Symbol	Description	Min	Typ	Max	Unit
R ₂₅	T _C = 25 °C		5		kΩ
ΔR/R	T _C = 100 °C, R ₁₀₀ = 481 Ω			±5	%
P ₂₅	T _C = 25 °C		50		mW
B _{25/50}	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298.15 \text{ K}))]$		3380		K
B _{25/80}	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298.15 \text{ K}))]$		3440		K

Module

Symbol	Description		Min	Typ	Max	Unit
V _{iso}	Isolation Voltage (All Terminals Shorted)	f = 50 Hz, 1 minute	2500			V
T _J	Maximum Junction Temperature				175	°C
T _{JOP}	Maximum Operating Junction Temperature Range		-40		+150	°C
T _{stg}	Storage Temperature		-40		+125	°C
R _{θCS}	Case-To-Sink Thermally (Conductive Grease Applied)			0.02		°C/W
T	Power Terminals Screw: M6		3.0		6.0	N·m
T	Mounting Screw: M5		3.0		6.0	N·m
G	Weight			390		g

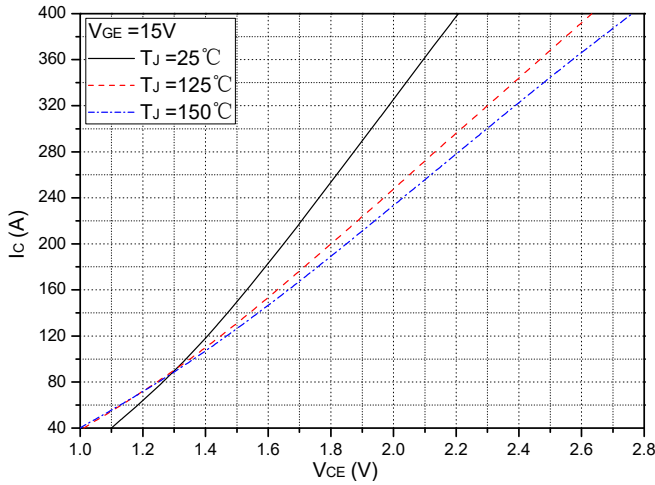


Fig.1 Typical Saturation Voltage Characteristics(chip)

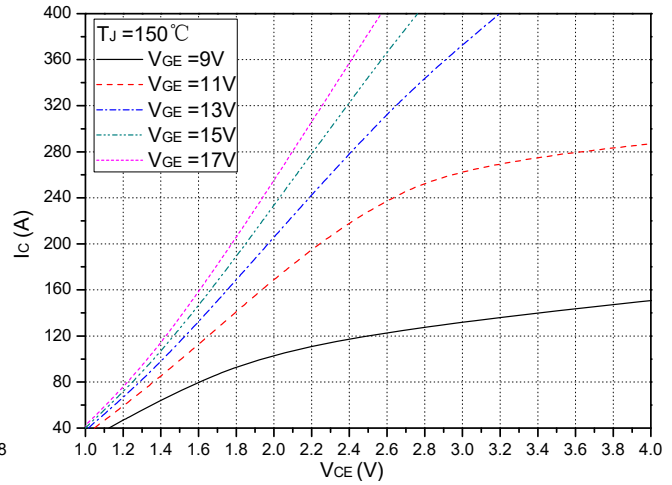


Fig.2 Typical Output Characteristics(chip)

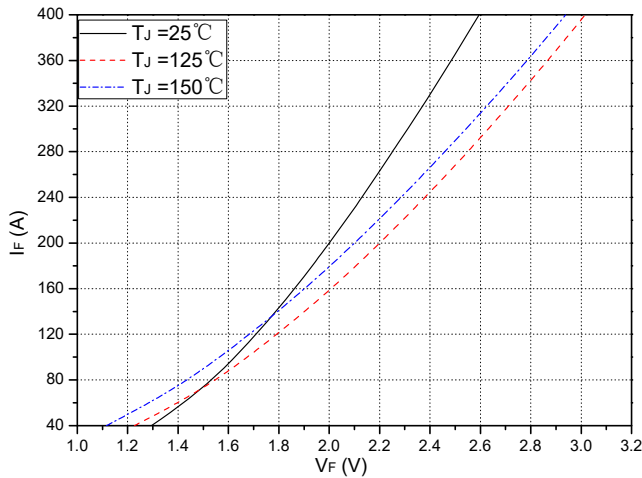


Fig.3 Forward Characteristics of Diode (chip)

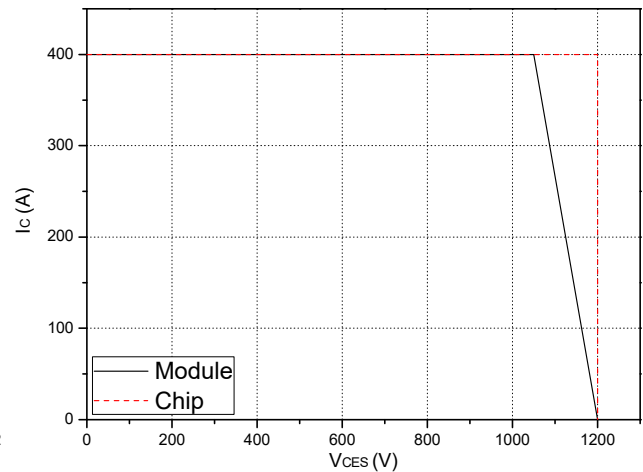


Fig.4 Reverse Bias Safe Operation Area (RBSOA)

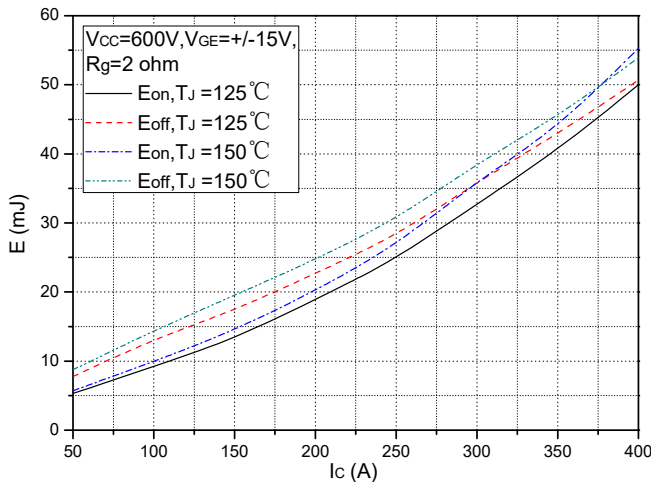


Fig.5 Typical Switching Loss vs. Collector Current

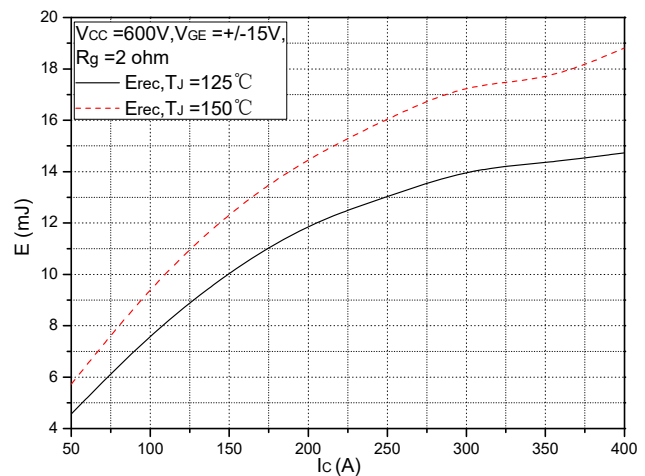


Fig.6 Typical Switching Loss vs. Collector Current

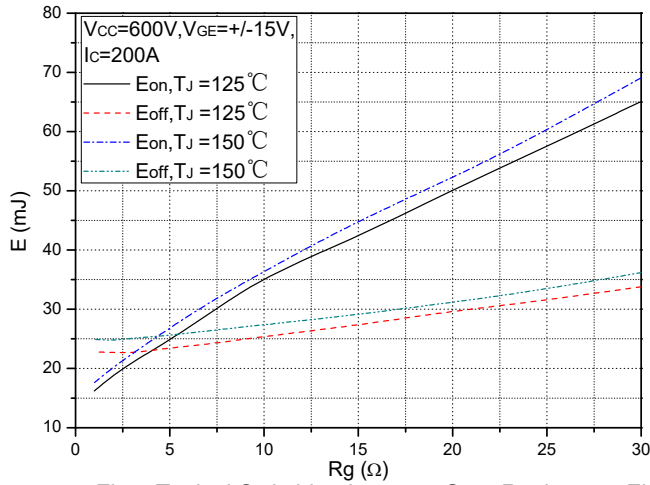


Fig.7 Typical Switching Loss vs. Gate Resistance Fig.8 Typical Switching Loss vs. Gate Resistance

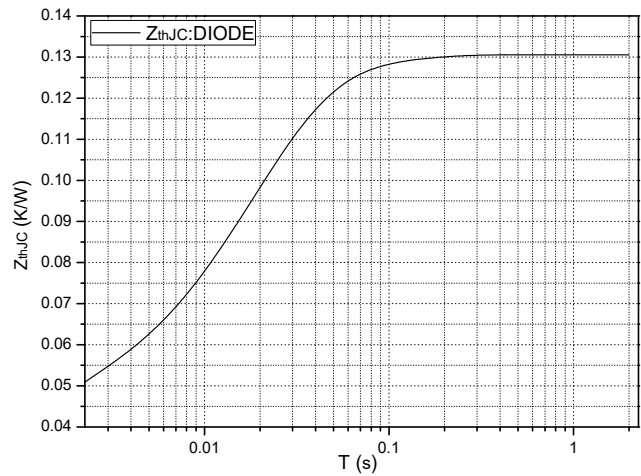
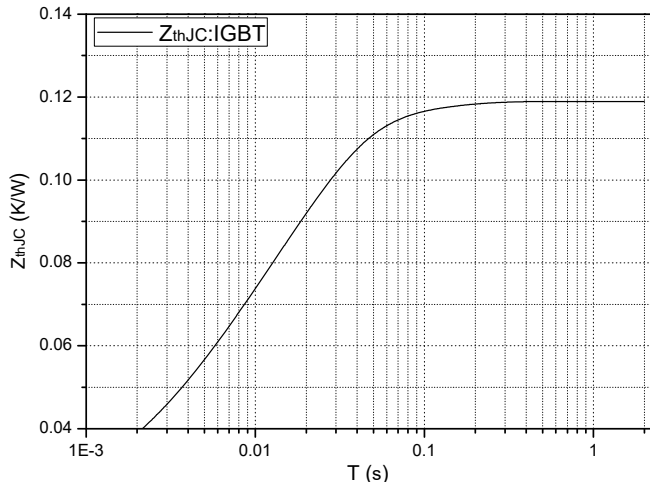
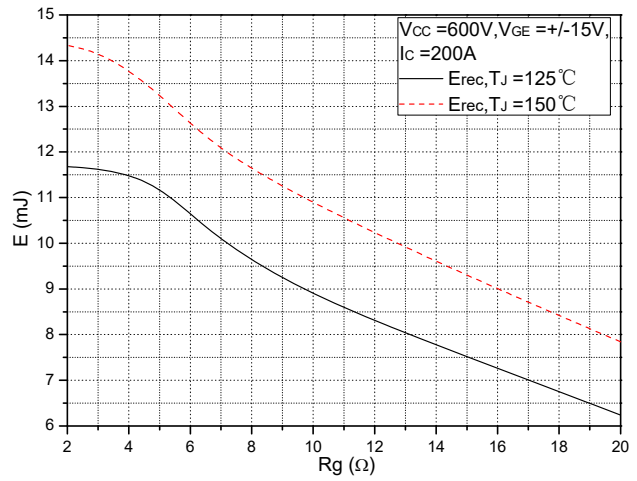


Fig.9 Transient thermal impedance (IGBT) Fig.10 Transient thermal impedance (Diode)

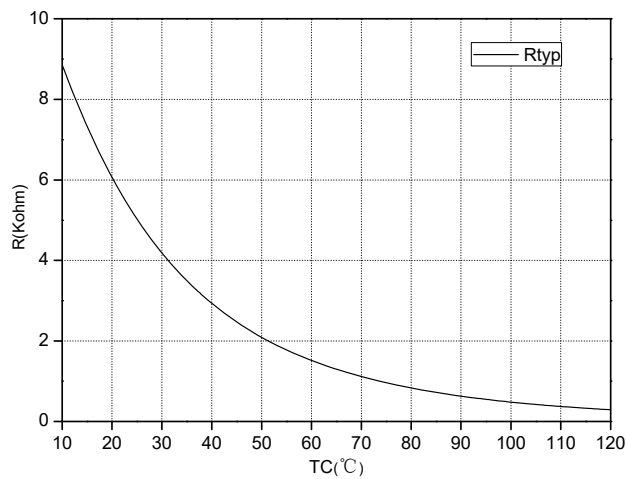
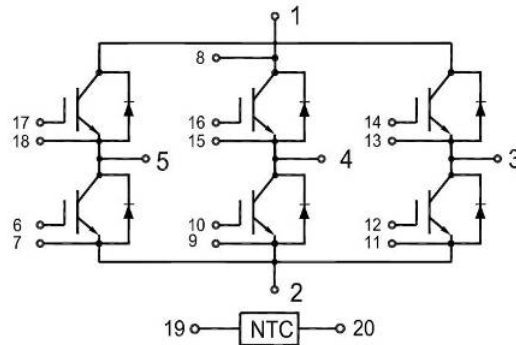
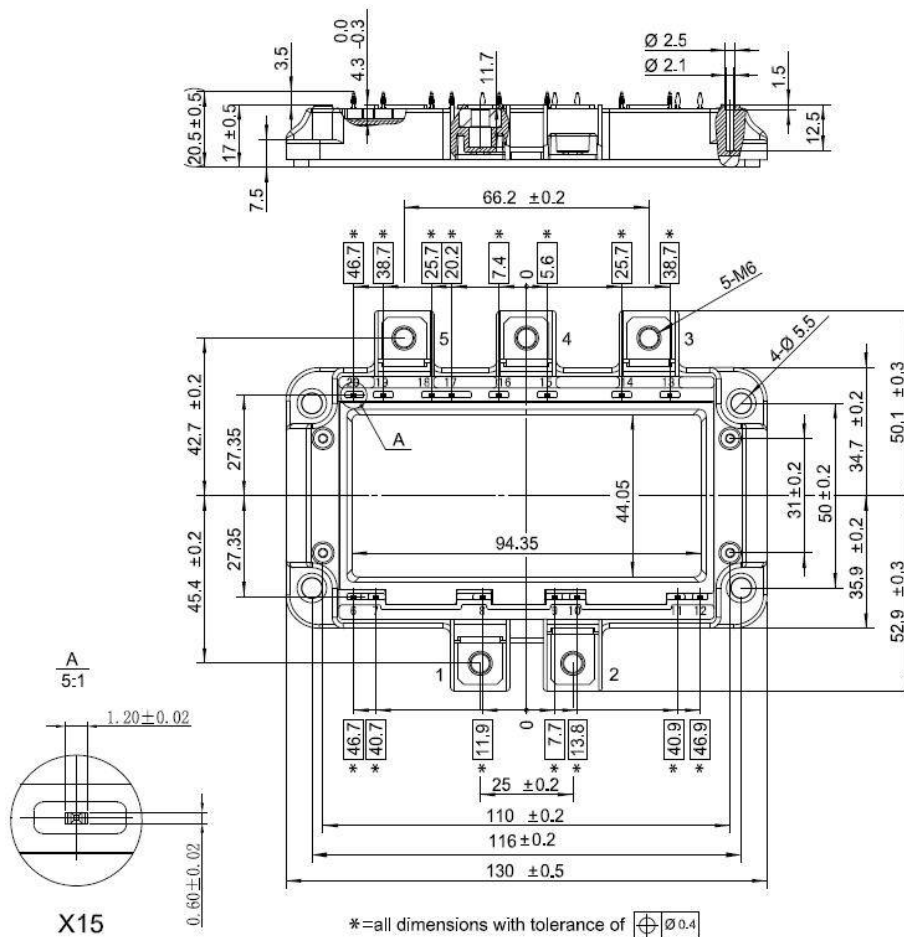
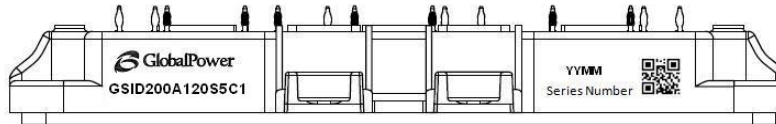


Fig.11 NTC Temperature characteristics

Internal Circuit



Package Outline (Unit: mm):



Revision History

Date	Revision	Notes
10/23/2015	0.1	Initial release of preliminary datasheet.
11/15/2015	0.2	Add the test data at junction temperature of 150°C.
12/28/2015	0.3	Update the freewheeling diode specifications.
01/31/2016	0.4	Add the internal gate resistor parameter
01/03/2020	0.5	Applied company name change
03/20/2020	0.6	Revise internal IGBT data

Notes

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented March, 2013. RoHS Declarations for this product can be obtained from the Product Documentation sections of www.SemiQ.com.

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